

Single-Crystal Alkali Antimonide Photocathodes: High Efficiency in the Ultrathin Limit

C. T. Parzyck^{1,*}, A. Galdi^{2,*}, J. K. Nangoi¹, W. J. I. DeBenedetti³, J. Balajka³, B. D. Faeth⁴,
 H. Paik⁴, C. Hu¹, T. A. Arias¹, M. A. Hines³, D. G. Schlom^{5,6,7}, K. M. Shen^{1,6} and J. M. Maxson^{2,†}
¹*Department of Physics, Laboratory of Atomic and Solid State Physics, Cornell University, Ithaca, New York 14853, USA*
²*Cornell Laboratory for Accelerator-Based Sciences and Education, Cornell University, Ithaca, New York 14853, USA*
³*Department of Chemistry and Chemical Biology, Cornell University, Ithaca, New York 14853, USA*
⁴*Platform for the Accelerated Realization, Analysis, and Discovery of Interface Materials (PARADIM),
 Cornell University, Ithaca, New York 14853, USA*
⁵*Department of Materials Science and Engineering, Cornell University, Ithaca, New York 14853, USA*
⁶*Kavli Institute at Cornell for Nanoscale Science, Cornell University, Ithaca, New York 14853, USA*
⁷*Leibniz-Institut für Kristallzüchtung, Max-Born-Straße 2, 12489 Berlin, Germany*



(Received 30 December 2021; accepted 2 February 2022; published 18 March 2022)

The properties of photoemission electron sources determine the ultimate performance of a wide class of electron accelerators and photon detectors. To date, all high-efficiency visible-light photocathode materials are either polycrystalline or exhibit intrinsic surface disorder, both of which limit emitted electron beam brightness. In this Letter, we demonstrate the synthesis of epitaxial thin films of Cs₃Sb on 3C-SiC (001) using molecular-beam epitaxy. Films as thin as 4 nm have quantum efficiencies exceeding 2% at 532 nm. We also find that epitaxial films have an order of magnitude larger quantum efficiency at 650 nm than comparable polycrystalline films on Si. Additionally, these films permit angle-resolved photoemission spectroscopy measurements of the electronic structure, which are found to be in good agreement with theory. Epitaxial films open the door to dramatic brightness enhancements via increased efficiency near threshold, reduced surface disorder, and the possibility of engineering new photoemission functionality at the level of single atomic layers.

DOI: [10.1103/PhysRevLett.128.114801](https://doi.org/10.1103/PhysRevLett.128.114801)

Dense and coherent electron beams generated via photoemission have enabled many revolutionary tools in the physical sciences. These include x-ray-free electron lasers with 10⁹ times higher peak x-ray brightness than previous sources [1,2], ultrafast electron microscopes that achieve femtosecond temporal and atomic structural resolution [3,4], hadron collider luminosity-enhancing systems based on electron beams [5], and next-generation electron linear colliders [6,7], which will probe physics beyond the standard model. Electron beam brightness, defined as the density of the beam in position-momentum phase space, is a central figure of merit for each of these applications [8]. According to Liouville's theorem, the brightness of any electron beam in a linear accelerator can be no greater than at its source [9,10]. Thus, the photoemission performance of photocathodes can determine the ultimate performance of accelerators ranging from meters to kilometers in length [11]. Photocathodes are also the critical enabling technology for many photon detectors, ranging from photomultipliers [12], image intensifiers, and ultrafast time-resolved streak cameras [13] to detectors for high-energy physics applications [14].

For intense beam generation or sensitive detection applications, many metallic photocathodes are infeasible choices due to their low quantum efficiencies (QEs)—the

number of emitted electrons per incident photon. For metals, QEs generally range from 10⁻³ to 10⁻⁵ with ultraviolet illumination [15]. In contrast, the highest quantum efficiency materials, semiconductors containing or coated with alkali metals, have peak quantum efficiencies exceeding 1% in the visible region, with response extending into the near-infrared range [15]. In particular, the spectral response of alkali antimonides extends near the lasing wavelength of common high-bandwidth gain media and therefore can eliminate lossy wavelength conversion stages in both accelerator and detector applications [16–18]. Additionally, by limiting the required light intensity for a given photoelectron density, high quantum efficiency can mitigate multiphoton photoemission (MPPE). Since MPPE causes a dramatic increase in the momentum spread of photoelectrons, its suppression can dramatically improve beam brightness [19].

Owing to momentum conservation in the photoemission process, the transverse momentum spread of photoelectrons from clean, ordered, crystalline surfaces can be reduced by exploiting the material's band structure [20]. For single-crystal metal photocathodes, this has been theoretically modeled and experimentally verified [21,22]. Record low-momentum spread has been achieved in Cu (100) near the photoemission threshold; however, the efficiency ($\sim 10^{-8}$)

is too low for the beam current requirements of moderate- to high-intensity applications [22]. It is therefore desirable to synthesize maximally efficient cathodes as single-crystal films, where the smoothness, homogeneity, and termination can be controlled.

To date, all high-efficiency visible-light photocathodes are either grown as (often defect-rich) polycrystals or produced by activating a semiconductor surface (e.g., GaAs) with an alkali metal, commonly cesium, resulting in an intrinsically disordered emitter surface [23–25]. Owing to their alkali metal content, these photocathodes are extremely sensitive to vacuum contamination and cannot be characterized *ex situ*; a single Langmuir of oxygen is sufficient to alter their efficiency and surface chemistry [26–29]. While great progress has been made in the growth of alkali antimonide films using evaporative and sputtering techniques [30–35], smooth, epitaxial, single-phase samples remain elusive. This presents a barrier not only to the reduction of physical [36,37] and surface potential [38] roughness, but also to the engineering of these unique low-work-function semiconducting materials.

In this Letter, we demonstrate the first epitaxial growth of thin films of the high-efficiency photocathode material Cs_3Sb via molecular-beam epitaxy. The resulting films were characterized using a variety of *in situ* diagnostics including reflection high-energy electron diffraction (RHEED), x-ray and ultraviolet photoemission spectroscopy (XPS, UPS), and angle-resolved photoemission spectroscopy (ARPES). Structural and spectroscopic measurements of our films agree well with both previous studies of polycrystalline samples and density-functional theory (DFT) calculations of the electronic structure.

Cs_3Sb has a photoemission threshold > 600 nm, QE exceeding 1% at 530 nm, and crystallizes exclusively in a cubic structure with lattice constant a_{bulk} in the range of 9.14–9.19 Å [15,39–44]. Earlier work identified a $F_{d\bar{3}m}$ space group (NaTi-like) [39,41], while more recent studies favor an ordered $F_{m\bar{3}m}$ Cu_3Al structure [40,44]. The large cubic lattice constant presents a challenge in the selection of a suitable substrate; however, recent studies have identified 3C-SiC as a promising candidate due to its lattice parameter $a_{\text{SiC}} = 4.36$ Å, nearly matching $a_{\text{bulk}}/2 \approx 4.59$ (~5% strain), and the stability of its (001) surface [37,45].

Epitaxial thin films were grown on cubic 3C-SiC (001) substrates (epitaxial film on Si, MTI corporation) via MBE, using a sequence of shuttered growth of two unit cells (u.c.) at a substrate temperature of 40 °C and a recrystallization step at 85 °C. This process is described schematically in Fig. 1(a). During the growth phase, Sb is provided in eight doses of 1/4 nominal monolayers per SiC unit cell, separated by a 20 s pause, while Cs is provided continuously. The sample is then heated to the recrystallization temperature in vacuum, annealed in Cs flux for 15 min, and cooled in Cs flux back to the growth temperature. Each

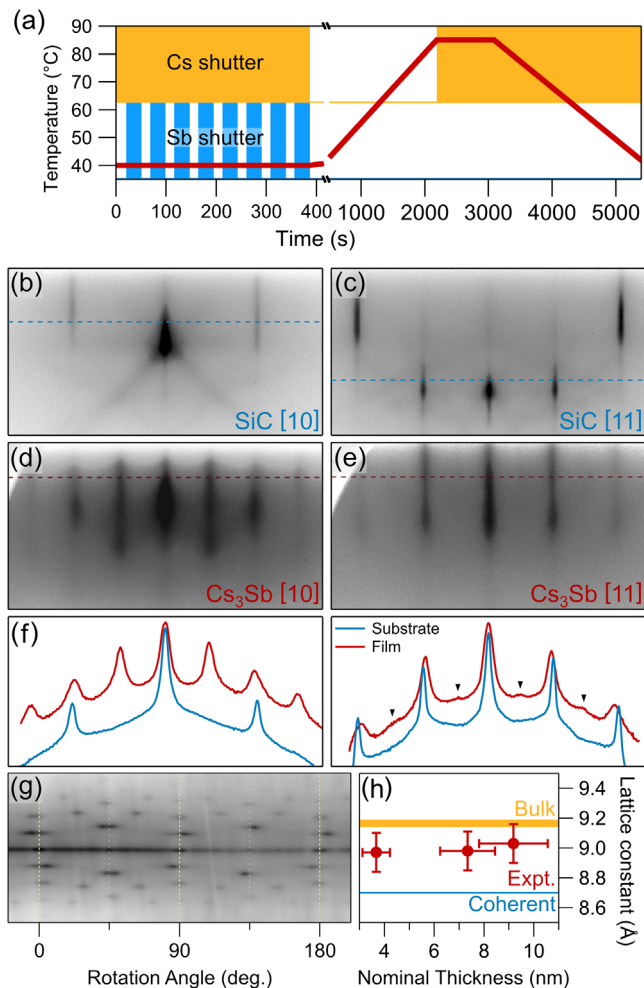


FIG. 1. Growth and structural characterization. (a) Substrate temperature (red line) and shutter states (filled areas, shutter open) during the growth and recrystallization process of 2 u.c. of (001)-oriented Cs_3Sb . RHEED images of an annealed SiC substrate (b),(c) and a 10 u.c. Cs_3Sb film (d),(e) along corresponding azimuths. (f) Line profiles of the substrate (blue) and film (red) along dashed lines in the above RHEED images (offset for clarity); half-order peaks are marked with black triangles. (g) RHEED line profile intensity of a 10 u.c. film as a function of the azimuthal angle ($0^\circ = [10]$, $45^\circ = [11]$). (h) In-plane lattice constant of three samples, measured using RHEED, grown under nominally identical conditions. Orange and blue lines mark the bulk Cs_3Sb lattice parameter and $2 \times a_{\text{SiC}}$, respectively. A logarithmic intensity scale is used in (b)–(g).

cycle produces nominally 2 u.c. of Cs_3Sb , within the $\pm 15\%$ uncertainty of the quartz-crystal microbalance measurement of the Sb flux. This growth process departs from traditional codeposition procedures in favor of a solid-phase epitaxy approach as we have observed that films grown by codeposition at a single temperature are either crystalline or efficient photoemitters, but not both simultaneously. Films codeposited at low temperatures (< 80 °C) appear stoichiometric and have high QE, but lack ordered surfaces. Conversely, films codeposited at

higher temperatures (90 °C – 150 °C) form an ordered crystalline phase, but are generally Cs deficient (measured by XPS) and have low QE ($< 1 \times 10^{-4}$ at 532 nm). A low deposition temperature is necessary to reduce the Cs desorption rate and produce the correct stoichiometry; then the anneal is required to improve crystallinity and order the domains to produce an epitaxial film.

RHEED patterns of a SiC substrate and a 10 u.c. (nominally 9.2–9.5 nm) thick film are displayed in Fig. 1(b)–1(e). Comparison of the film diffraction patterns with the reciprocal lattice of Cs₃Sb confirm the cube-on-cube epitaxial relationship between film and substrate: Cs₃Sb(100)//SiC(100). The in-plane ordering of the film is confirmed by a RHEED line profile intensity map presented in Fig. 1(g). This map shows both a 90° period, consistent with cubic symmetry, and no repetition of the Bragg peaks within a 45° window, precluding the presence of rotationally misaligned macroscopic domains. From the RHEED diffraction streak spacing, the in-plane lattice constant for the thinnest (4 u.c.) film is found to be $a_{\text{film}} = 8.97 \pm 0.13$ Å, indicating partial relaxation ($2 \times a_{\text{SiC}} < a_{\text{film}} < a_{\text{bulk}}$) at a thickness of only 3.8 nm. In Fig. 1(e), weak half-order streaks are present in the RHEED pattern along the [11] azimuth, evidenced by the line profiles in Fig. 1(f). These correspond to forbidden odd-index reflections in either the $F_{m\bar{3}m}$ or the $F_{d\bar{3}m}$ Cs₃Sb structure; their presence may signal the presence of lattice distortions (either intrinsic or induced by defects or vacancies) or a surface reconstruction.

To confirm the formation of the Cs₃Sb phase, *in situ* XPS measurements were performed and typical spectra are reported in Fig. 2. The dominant peaks in the Sb region correspond to the 3– valence, as expected for Cs₃Sb, while weak features corresponding to more oxidized species (1–, 3+) are also visible at higher binding energy. Between the Sb 3d_{3/2} and 3d_{5/2} peaks, weak peaks assigned to O 1s states of various Cs and Sb oxides are also visible, typical of Cs₃Sb that has been exposed to trace amounts of oxygen [26,28,29]. We attribute the surface oxidation to reaction with residual gasses in the UHV transfer system. The Cs 3d_{5/2} peak, Fig. 2(b), is shifted to slightly higher binding energy than the 1+ reference, attributed to band bending induced by surface oxidation [29], and is accompanied by a strong plasmon peak—typically correlated with high quantum efficiency [46,47]. Finally, valence band measurements, Fig. 2(c), agree with data on polycrystalline films reported in [46]. In particular, the Cs 5s to Cs 5p peak-area ratios closely match those reported by Bates *et al.* for high QE Cs₃Sb (attributed to minimal excess metallic Cs on the surface). We find area ratios ranging from 0.23 to 0.30 (or 0.15–0.21 if the Sb 4d tail contributions are subtracted) for samples with QE ranging from 2.1% to 3.3%.

Following growth, the QE of the samples was measured in an adjoining chamber using a biased collection coil.

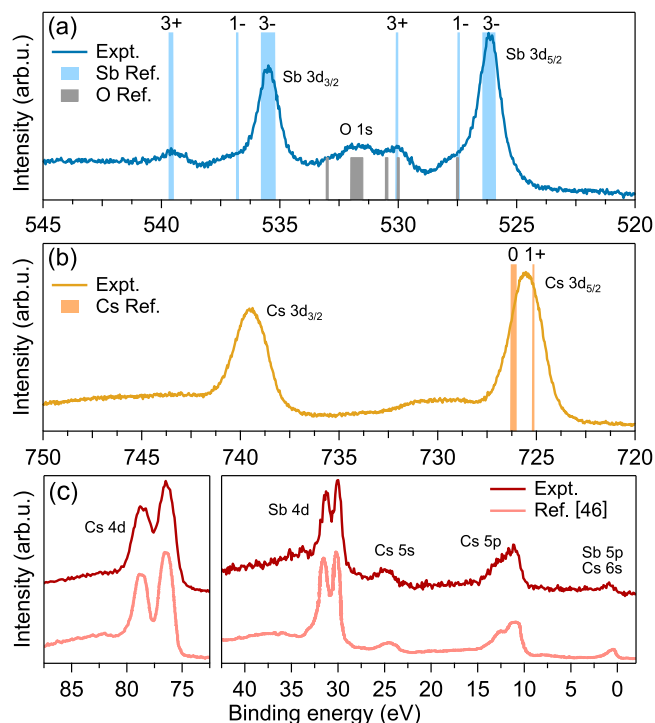


FIG. 2. XPS Spectra of a 7.4 nm thick epitaxial Cs₃Sb film. (a) Sb 3d and O 1s regions. Cyan bars indicate binding energy references for different Sb species; gray bars denote the O 1s references for different oxides. (b) Cs 3d region of the same sample. Orange bars indicate the literature references for the Cs oxidation states. (c) Valence band spectra including Cs 4d, 5s, 6s, and Sb 4d and 5p regions. Data from a high-efficiency polycrystalline Cs₃Sb film (reproduced from [46]) are provided for reference.

The QE of the ~10 nm (10 u.c.) sample of Figs. 1(d) and 1(e) is shown in Fig. 3, demonstrating that its quantum efficiency exceeds 3% below 532 nm and is significantly enhanced at 650 nm (0.24%) compared to typical polycrystalline Cs₃Sb on silicon. In the inset, we report the QE (at 532 nm) of a sequentially grown thickness series; the QE exceeds 2% for the 4 u.c. sample and is not strongly affected by increasing thickness up to 9 nm. It is unlikely that the measured photocurrent includes electrons excited from the substrate since silicon carbide is a 2.3 eV indirect band gap semiconductor where direct optical transitions require photon energies exceeding 4 eV [48], well outside the measurement range. The measured thickness dependence departs from that of previous polycrystalline samples and represents an interesting avenue for future research.

Thickness is a critical parameter in determining a photocathode’s response time—the resulting electron pulse length following illumination by a delta-function optical impulse. For semiconductor photocathodes, this is governed by the transit time of excited electrons to the surface [49] and is naturally restricted in thin samples. In our case, the electron transit time is expected to be on order ~10 fs, based on our DFT-based *ab initio* photoemission

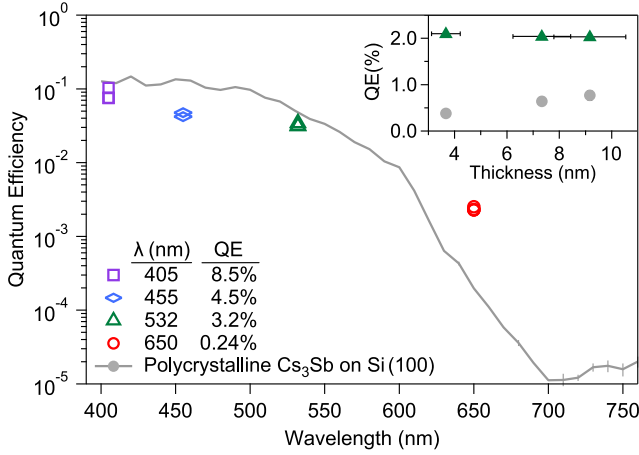


FIG. 3. Quantum efficiency, as a function of wavelength, for one sample, measured at two locations on the surface. The QE of a representative codeposited sample grown on Si (100) is included for comparison. Inset: the QE, at 532 nm, of three samples of varying thickness grown under the same nominal conditions (triangles) and the QE of the codeposited sample on Si whose spectral response is reported in the main figure (dots). The QE of a representative, codeposited, 116 ± 15 nm thick sample grown on Si (100) is included for comparison.

calculations. This suggests that these thin, epitaxial cathodes are excellent candidates for time-resolved electron beam instruments such as ultrafast microscopes [50] or high time-resolution streak cameras [13].

There is significant evidence that the electronic band structure, in concert with many-body effects, determines the momentum distribution of photoemitted electrons from atomically ordered surfaces, even when the photon energy is very near the photocathode work function

[20–22,51,52]—where brightness is often largest [8,18]. Nonetheless, the minimum mean transverse energy measured in polycrystalline Cs_3Sb , ~ 20 meV at 90 K [53], is a factor of 2.6 larger than the free-electron thermal limit estimate [54] and an order of magnitude larger than the minimum predicted by our DFT-based *ab initio* photoemission theory [55]. Fully utilizing the electron band structure and maximizing photoemission brightness requires an atomically ordered surface [21,52,56], which has not been possible in alkali antimonides until now.

A major advantage of the epitaxial growth method presented here is that the resulting Cs_3Sb films possess sufficiently ordered surfaces such that the band structure is observed in the photoemitted electrons and can be measured using ARPES for comparison with theoretical calculations. Measurements were performed at room temperature in a background pressure of $P < 1 \times 10^{-10}$ torr using a helium plasma discharge lamp and the results are summarized in Fig. 4. Because of the highly three-dimensional nature of the band structure, determination of the out-of-plane momentum k_z is required to make quantitative comparisons to DFT calculations. We estimate the inner potential to be $V_0 = \phi + W$ [57] using the bandwidth $W \approx 1.2$ eV estimated from UPS spectra and the work function $\phi \approx 1.7$ eV measured from polycrystalline samples. This yields estimates of $k_z \approx 2.4$ and $k_z \approx 3.3 \text{ \AA}^{-1}$ for He-I ($h\nu = 21.2$ eV) and He-II ($h\nu = 40.8$ eV), respectively. To assign the absolute momenta to positions in the Brillouin zone, in the presence of uncertainty in the out-of-plane lattice constant c_{film} , comparison of the ARPES spectra and DFT calculations is performed across several independent measurements (cf. Supplemental Material [58]). This gives a best fit with $k_z = 1.63$ reciprocal lattice units (r.l.u., where

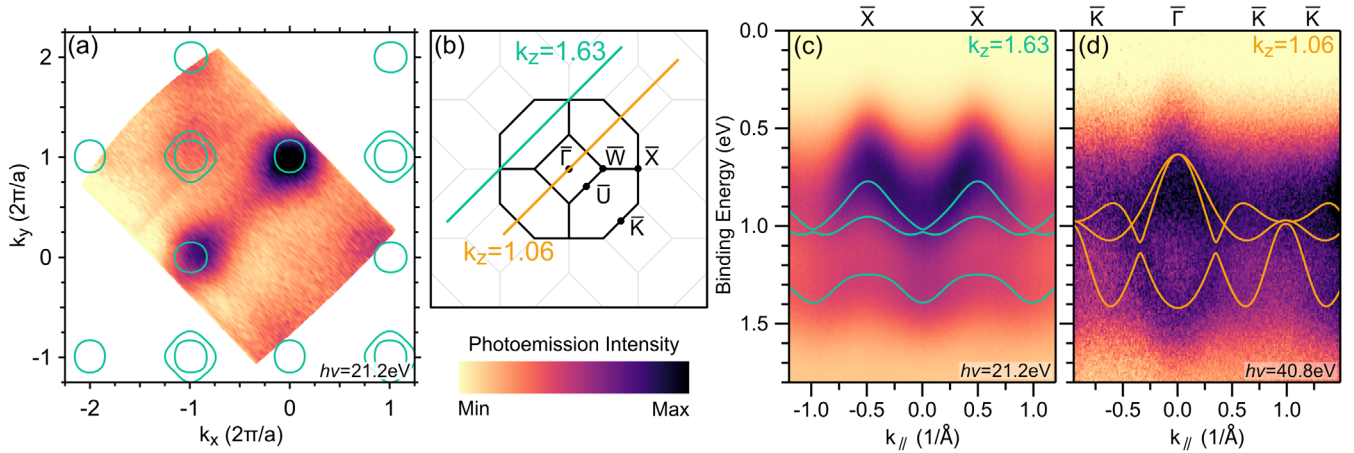


FIG. 4. *In situ* ARPES measurements of Cs_3Sb thin films. (a) Constant-energy intensity map integrated over a 50 meV window about $E - E_f = -0.55$ eV. Overlay (green) shows band positions at $E - E_{\text{VBM}} = -0.19$ eV calculated by DFT. (b) Schematic of the projected fcc Brillouin zone showing locations of the cuts shown in (c),(d). (c) ARPES spectrum passing through the edge of the projected zone at a nominal out-of-plane momentum of $k_z = 1.63$ r.l.u. Corresponding calculated band positions are shown in green. (d) Spectrum taken through the zone center at $k_z = 1.03$ r.l.u. with calculated bands overlaid in orange. In (c),(d) the DFT bands have been offset in energy by -0.63 eV.

1 r.l.u. = $2\pi/c_{\text{film}}$) for He-I and $k_z = 1.06$ r.l.u. for He-II along with an overall shift of the Fermi level by 0.63 eV (attributable to pinning of E_f in the gap)—consistent with an inner potential of $V_0 = 3.2$ eV and lattice constant of $c_{\text{film}} = 9.5$ Å.

Figure 4(a) shows a photoemission intensity map taken with He-I light at $E - E_f = 0.550$ eV, just cutting through the tops of the valence bands. The measured intensity pattern is consistent with a fcc Brillouin zone with $a_{\text{film}} = 9.0$ Å. An overlay showing the calculated tops of the valence bands (at the same k_z and at an energy of $E - E_{VBM} = -0.190$ eV) agrees well with identified band positions. Figure 4(c) shows a cut along the $\bar{X} - \bar{X}$ direction taken with He-I light and Fig. 4(d) shows a cut along the $\bar{K} - \bar{\Gamma} - \bar{K}$ line taken with He-II. In the $\bar{X} - \bar{X}$ cut, we observe good agreement between the predicted and observed bands, with one brighter set between 0.5 and 1.0 eV of binding energy separated from a heavier and less intense band between 1.2 and 1.5 eV. In the $\bar{K} - \bar{\Gamma} - \bar{K}$ cut, we again observe a reasonable match between the predicted and observed dispersions—in particular, the holelike band at $\bar{\Gamma}$, at a k_z of 1.06 r.l.u., lies nominally at the X point of the fcc zone and constitutes the valence band maximum.

While there is good qualitative agreement with our calculations, we observe a roughly 10%–20% larger bandwidth in the ARPES spectra than is predicted by DFT. Preliminary calculations indicate that the Sb 3*p*–Cs 6*s* bandwidth is influenced by the presence of both distortions from the ideal $F_{m\bar{3}m}$ structure and by biaxial compressive strain. The effects are found to be in competition, with distortions decreasing the bandwidth and strain increasing it, so we cannot disentangle their individual effects at present. This motivates further *in situ* structural characterization of this epitaxial phase, such as x-ray diffraction measurements [31–34] and a more detailed study of strain effects on the photoemission processes of Cs₃Sb.

In conclusion, we have used solid-phase epitaxy to grow (001)-oriented Cs₃Sb films on 3C-SiC (001) substrates. These films display unusually high efficiency at thicknesses as low as 4 u.c. (~3.8 nm). Thanks to the ordered nature of the sample surface, we have obtained the first ARPES measurements of the band structure, allowing direct comparison with DFT. As an indicator of what may be possible in the future, epitaxial control in other classes of semiconducting photocathodes has yielded remarkable new capabilities. Epitaxial strain induced in a GaAs/GaAsP superlattice lifts a band degeneracy at the valence band maximum and significantly enhances the spin polarization of the emitted electrons [82]. An even more intricate epitaxial layered structure enables an interferometric enhancement of absorption in GaAs, improving quantum efficiency by nearly an order of magnitude [83]. Control of the surface dipole moment in epitaxial GaN, an ultraviolet semiconductor photocathode, yields a negative electron affinity surface without cesium, greatly enhancing its intrinsic quantum

efficiency and ease of use [84]. This Letter opens the door to similar engineering at the level of single atomic layers in the alkali antimonides: controlled doping, strain, termination, surface dipole moment, and heterostructuring are prime targets of future work for enhanced brightness in these remarkable photoemissive compounds.

The data that support the findings of this study are available within this Letter, Supplemental Material [58], and a data repository [85], including additional data related to the growth and structural characterization. Any additional data connected with the study are available from the corresponding author upon reasonable request.

This work was supported by the U.S. National Science Foundation Grants No. PHY-1549132, the Center for Bright Beams, DMR-2104427, and by the National Science Foundation [Platform for the Accelerated Realization, Analysis, and Discovery of Interface Materials (PARADIM)] under Cooperative Agreement No. DMR-2039380. This work made use of the Cornell Center for Materials Research Shared Facilities, which are supported through the NSF MRSEC program (DMR-1719875).

*C. T. P and A. G. contributed equally to this work.

†Corresponding author.

jmm586@cornell.edu

- [1] P. Emma *et al.*, First lasing and operation of an Angstrom-wavelength free-electron laser, *Nat. Photonics* **4**, 641 (2010).
- [2] M. Scholz, FEL performance achieved at European XFEL, *Proceedings of the 9th International Particle Accelerator Conference IPAC2018, Vancouver, Canada, International Particle Accelerator Conference* (JACoW Publishing, Geneva, 2018).
- [3] V. A. Lobastov, R. Srinivasan, and A. H. Zewail, Four-dimensional ultrafast electron microscopy, *Proc. Natl. Acad. Sci. U.S.A.* **102**, 7069 (2005).
- [4] G. Sciaini and R. J. D. Miller, Femtosecond electron diffraction: heralding the era of atomically resolved dynamics, *Rep. Prog. Phys.* **74**, 096101 (2011).
- [5] V. N. Litvinenko and Y. S. Derbenev, Coherent Electron Cooling, *Phys. Rev. Lett.* **102**, 114801 (2009).
- [6] M. Bai *et al.*, C³: A “cool” route to the Higgs boson and beyond, [arXiv:2110.15800](https://arxiv.org/abs/2110.15800).
- [7] S. Michizono, The international linear collider, *Nat. Rev. Phys.* **1**, 244 (2019).
- [8] P. Musumeci, J. Giner Navarro, J. Rosenzweig, L. Cultrera, I. Bazarov, J. Maxson, S. Karkare, and H. Padmore, Advances in bright electron sources, *Nucl. Instrum. Methods Phys. Res., Sect. A* **907**, 209 (2018).
- [9] I. V. Bazarov, B. M. Dunham, and C. K. Sinclair, Maximum Achievable Beam Brightness from Photoinjectors, *Phys. Rev. Lett.* **102**, 104801 (2009).
- [10] D. Filippetto, P. Musumeci, M. Zolotarev, and G. Stupakov, Maximum current density and beam brightness achievable by laser-driven electron sources, *Phys. Rev. ST Accel. Beams* **17**, 024201 (2014).

- [11] C. M. Pierce, M. B. Andorf, E. Lu, C. Gulliford, I. V. Bazarov, J. M. Maxson, M. Gordon, Y.-K. Kim, N. P. Norvell, B. M. Dunham, and T. O. Raubenheimer, Low intrinsic emittance in modern photoinjector brightness, *Phys. Rev. ST Accel. Beams* **23**, 070101 (2020).
- [12] A. G. Wright, *The Photomultiplier Handbook* (Oxford University Press, New York, 2017).
- [13] J. Liang, L. Zhu, and L. V. Wang, Single-shot real-time femtosecond imaging of temporal focusing, *Light* **7**, 42 (2018).
- [14] A. Lyashenko, B. Adams, M. Aviles, T. Cremer, C. Ertley, M. Foley, M. Minot, M. Popecki, M. Stochaj, W. Worstell, J. Elam, A. Mane, O. W. Siegmund, H. Frisch, A. Elagin, E. Angelico, and E. Spieglan, Performance of large area picosecond photo-detectors (LAPPDTM), *Nucl. Instrum. Methods Phys. Res., Sect. A* **958**, 162834 (2020).
- [15] A. Sommer, *Photoemissive Materials: Preparation, Properties, and Uses* (Krieger, New York, 1980).
- [16] P. Musumeci, L. Cultrera, M. Ferrario, D. Filippetto, G. Gatti, M. S. Gutierrez, J. T. Moody, N. Moore, J. B. Rosenzweig, C. M. Scoby, G. Travish, and C. Vicario, Multiphoton Photoemission from a Copper Cathode Illuminated by Ultrashort Laser Pulses in an rf Photoinjector, *Phys. Rev. Lett.* **104**, 084801 (2010).
- [17] L. Cultrera, C. Gulliford, A. Bartnik, H. Lee, and I. Bazarov, Ultra low emittance electron beams from multi-alkali antimonide photocathode operated with infrared light, *Appl. Phys. Lett.* **108**, 134105 (2016).
- [18] J. Maxson, L. Cultrera, C. Gulliford, and I. Bazarov, Measurement of the tradeoff between intrinsic emittance and quantum efficiency from a NaKSb photocathode near threshold, *Appl. Phys. Lett.* **106**, 234102 (2015).
- [19] J. K. Bae, I. Bazarov, P. Musumeci, S. Karkare, H. Padmore, and J. Maxson, Brightness of femtosecond nonequilibrium photoemission in metallic photocathodes at wavelengths near the photoemission threshold, *J. Appl. Phys.* **124**, 244903 (2018).
- [20] B. L. Rickman, J. A. Berger, A. W. Nicholls, and W. A. Schroeder, Intrinsic Electron Beam Emittance from Metal Photocathodes: The Effect of the Electron Effective Mass, *Phys. Rev. Lett.* **111**, 237401 (2013).
- [21] S. Karkare, W. Wan, J. Feng, T. C. Chiang, and H. A. Padmore, One-step model of photoemission from single-crystal surfaces, *Phys. Rev. B* **95**, 075439 (2017).
- [22] S. Karkare, G. Adhikari, W. A. Schroeder, J. K. Nangoi, T. Arias, J. Maxson, and H. Padmore, Ultracold Electrons via Near-Threshold Photoemission from Single-Crystal Cu (100), *Phys. Rev. Lett.* **125**, 054801 (2020).
- [23] T. Yamada, J. Fujii, and T. Mizoguchi, STM, STS, and local work function study of Cs/p-GaAs(110), *Surf. Sci.* **479**, 33 (2001).
- [24] R. Fukuzoe, M. Hirao, D. Yamanaka, Y. Iwabuchi, H. Iijima, and T. Meguro, Preparation of Ga-terminated negative electron affinity-GaAs (100) surface by HCl-isopropanol treatment for nanoanalysis by scanning tunneling microscopy, *J. Vac. Sci. Technol. B* **36**, 06JK01 (2018).
- [25] J. Biswas, J. Cen, M. Gaowei, O. Rahman, W. Liu, X. Tong, and E. Wang, Revisiting heat treatment and surface activation of GaAs photocathodes: In situ studies using scanning tunneling microscopy and photoelectron spectroscopy, *J. Appl. Phys.* **128**, 045308 (2020).
- [26] C. W. Bates, T. M. van Atekum, G. K. Wertheim, D. N. E. Buchanan, and K. E. Clements, X-ray photoemission studies of superficially oxidized cesium antimonide photoemitters, *Appl. Phys. Lett.* **38**, 387 (1981).
- [27] L. Danielson, C. Lee, and P. Oettinger, Laser illuminated high current photocathodes, *Appl. Surf. Sci.* **16**, 257 (1983).
- [28] L. Soriano and L. Galán, Interaction of cesium-potassium antimonide photocathode materials with oxygen: An x-ray photoelectron spectroscopy study, *Jpn. J. Appl. Phys.* **32**, 4737 (1993).
- [29] A. Galdi, W. J. I. DeBenedetti, J. Balajka, L. Cultrera, I. V. Bazarov, J. M. Maxson, and M. A. Hines, The effects of oxygen-induced phase segregation on the interfacial electronic structure and quantum efficiency of Cs₃Sb photocathodes, *J. Chem. Phys.* **153**, 144705 (2020).
- [30] J. Feng, S. Karkare, J. Nasiatka, S. Schubert, J. Smedley, and H. Padmore, Near atomically smooth alkali antimonide photocathode thin films, *J. Appl. Phys.* **121**, 044904 (2017).
- [31] M. Ruiz-Osés, S. Schubert, K. Attenkofer, I. Ben-Zvi, X. Liang, E. Muller, H. Padmore, T. Rao, T. Vecchione, J. Wong, J. Xie, and J. Smedley, Direct observation of bi-alkali antimonide photocathodes growth via in operando x-ray diffraction studies, *APL Mater.* **2**, 121101 (2014).
- [32] S. Schubert, J. Wong, J. Feng, S. Karkare, H. Padmore, M. Ruiz-Osés, J. Smedley, E. Muller, Z. Ding, M. Gaowei, K. Attenkofer, X. Liang, J. Xie, and J. Kühn, Bi-alkali antimonide photocathode growth: An x-ray diffraction study, *J. Appl. Phys.* **120**, 035303 (2016).
- [33] M. Gaowei, Z. Ding, S. Schubert, H. B. Bhandari, J. Sinsheimer, J. Kuehn, V. V. Nagarkar, M. S. J. Marshall, J. Walsh, E. M. Muller, K. Attenkofer, H. J. Frisch, H. Padmore, and J. Smedley, Synthesis and x-ray characterization of sputtered bi-alkali antimonide photocathodes, *APL Mater.* **5**, 116104 (2017).
- [34] Z. Ding, M. Gaowei, J. Sinsheimer, J. Xie, S. Schubert, H. Padmore, E. Muller, and J. Smedley, In-situ synchrotron x-ray characterization of K₂CsSb photocathode grown by ternary co-evaporation, *J. Appl. Phys.* **121**, 055305 (2017).
- [35] J. Xie, M. Demartean, R. Wagner, S. Schubert, M. Gaowei, K. Attenkofer, J. Walsh, J. Smedley, J. Wong, J. Feng, H. Padmore, M. Ruiz-Oses, Z. Ding, X. Liang, E. Muller, and I. Ben-Zvi, Synchrotron x-ray study of a low roughness and high efficiency K₂CsSb photocathode during film growth, *J. Phys. D* **50**, 205303 (2017).
- [36] J. Feng, S. Karkare, J. Nasiatka, S. Schubert, J. Smedley, and H. Padmore, Near atomically smooth alkali antimonide photocathode thin films, *J. Appl. Phys.* **121**, 044904 (2017).
- [37] A. Galdi, J. Balajka, W. J. I. DeBenedetti, L. Cultrera, I. V. Bazarov, M. A. Hines, and J. M. Maxson, Reduction of surface roughness emittance of Cs₃Sb photocathodes grown via codeposition on single crystal substrates, *Appl. Phys. Lett.* **118**, 244101 (2021).
- [38] S. Karkare and I. Bazarov, Effect of nanoscale surface roughness on transverse energy spread from GaAs photocathodes, *Appl. Phys. Lett.* **98**, 094104 (2011).
- [39] K. H. Jack and M. M. Wachtel, The characterization and crystal structure of caesium antimonide, a photo-electric surface material, *Proc. R. Soc. A* **239**, 46 (1957).
- [40] G. Gnutzmann, F. Wilhelm Dorn, and W. Klemm, Über einige A₃B- und AB₂-Verbindungen der schweren Alkalimetalle mit

- Elementen der V. Gruppe, *Z. Anorg. Allg. Chem.* **309**, 210 (1961).
- [41] W. H. McCarroll, Chemical and structural characteristics of the potassium-cesium-antimony photocathode, *J. Phys. Chem. Solids* **26**, 191 (1965).
- [42] J. M. Barois, C. Fouassier, M. Onillon, and B. Tanguy, Experimental study of the non stoichiometry of cesium antimonide: Cs₃Sb, *Mater. Chem. Phys.* **24**, 189 (1989).
- [43] J. Sangster and A. D. Pelton, The Cs-Sb (cesium-antimony) system, *J. Phase Equilib.* **18**, 382 (1997).
- [44] J. C. Robbie and A. H. Beck, Scanning electron diffraction studies on caesium antimonide photocathodes during formation, *J. Phys. D* **6**, 1381 (1973).
- [45] A. Galdi, C. T. Parzyck, W. J. I. DeBenedetti, J. Balajka, L. Cultrera, H. Paik, L. Moreschini, C. Hu, K. M. Shen, M. A. Hines, and J. M. Maxson, Understanding the growth dynamics Cs-Sb thin films via in-situ characterization techniques: Towards epitaxial alkali antimonide photocathodes, *Proceedings of the 12th International Particle Accelerator Conference (IPAC21), Campinas, Brazil* (JACoW Publishing, Geneva, 2021), pp. 2979–2982.
- [46] C. W. Bates, D. Das Gupta, L. Galan, and D. N. Buchanan, x-ray photoemission studies of cesium antimonide photoemitters, *Thin Solid Films* **69**, 175 (1980).
- [47] I. Martini, E. Chevallay, V. Fedosseev, C. Hessler, H. Neupert, V. Nistor, and M. Taborelli, X-ray photoemission spectroscopy studies of cesium antimonide photocathodes for photoinjector applications, *Phys. Procedia* **77**, 34 (2015).
- [48] G. L. Zhao and D. Bagayoko, Electronic structure and charge transfer in 3C- and 4H-SiC, *New J. Phys.* **2**, 16 (2000).
- [49] S. Karkare, L. Boulet, L. Cultrera, B. Dunham, X. Liu, W. Schaff, and I. Bazarov, Ultrabright and Ultrafast III–V Semiconductor Photocathodes, *Phys. Rev. Lett.* **112**, 097601 (2014).
- [50] M. T. Hassan, J. S. Baskin, B. Liao, and A. H. Zewail, High-temporal-resolution electron microscopy for imaging ultrafast electron dynamics, *Nat. Photonics* **11**, 425 (2017).
- [51] J. K. Nangoi, S. Karkare, R. Sundararaman, H. A. Padmore, and T. A. Arias, Importance of bulk excitations and coherent electron-photon-phonon scattering in photoemission from PbTe(111): Ab initio theory with experimental comparisons, *Phys. Rev. B* **104**, 115132 (2021).
- [52] S. Karkare, J. Feng, X. Chen, W. Wan, F. J. Palomares, T.-C. Chiang, and H. A. Padmore, Reduction of Intrinsic Electron Emittance from Photocathodes Using Ordered Crystalline Surfaces, *Phys. Rev. Lett.* **118**, 164802 (2017).
- [53] L. Cultrera, S. Karkare, H. Lee, X. Liu, I. Bazarov, and B. Dunham, Cold electron beams from cryocooled, alkali antimonide photocathodes, *Phys. Rev. ST Accel. Beams* **18**, 113401 (2015).
- [54] J. Feng, J. Nasiatka, W. Wan, S. Karkare, J. Smedley, and H. A. Padmore, Thermal limit to the intrinsic emittance from metal photocathodes, *Appl. Phys. Lett.* **107**, 134101 (2015).
- [55] J. K. Nangoi, S. Karkare, R. Sundararaman, G. Dodanduwa Waduge, J. K. Bae, A. Galdi, L. Cultrera, J. M. Maxson, I. V. Bazarov, H. A. Padmore, and T. A. Arias, Ab initio many-body calculations of the mean transverse energy for proposed high-brightness photocathode materials, in *The 5th Photocathode Physics for Photoinjectors Workshop Santa Fe, New Mexico, 2018*.
- [56] G. S. Gevorkyan, S. Karkare, S. Emamian, I. V. Bazarov, and H. A. Padmore, Effects of physical and chemical surface roughness on the brightness of electron beams from photocathodes, *Phys. Rev. ST Accel. Beams* **21**, 093401 (2018).
- [57] A. Damascelli, Probing the electronic structure of complex systems by ARPES, *Phys. Scr. T* **T109**, 61 (2004), 0307085.
- [58] See Supplemental Material at <http://link.aps.org/supplemental/10.1103/PhysRevLett.128.114801> for additional details and discussion concerning the growth optimization and DFT calculations as well as additional XPS, UPS, and ARPES spectra, which includes Refs. [59–81].
- [59] R. E. Honig and D. A. Kramer, Vapor pressure data for the solid and liquid elements, *RCA Rev.* **30**, 285 (1969).
- [60] D. Du, P. J. Strohbeen, H. Paik, C. Zhang, K. T. Genser, K. M. Rabe, P. M. Voyles, D. G. Schlom, and J. K. Kawasaki, Control of polymorphism during epitaxial growth of hyperferroelectric candidate LiZnSb on GaSb (111)B, *J. Vac. Sci. Technol. B* **38**, 022208 (2020).
- [61] M. Schlipf and F. Gygi, Optimization algorithm for the generation of ONCV pseudopotentials, *Comput. Phys. Commun.* **196**, 36 (2015).
- [62] R. Sundararaman, K. Letchworth-Weaver, K. A. Schwarz, D. Gunceler, Y. Ozhables, and T. Arias, JDFTx: Software for joint density-functional theory, *SoftwareX* **6**, 278 (2017).
- [63] N. Marzari, A. A. Mostofi, J. R. Yates, I. Souza, and D. Vanderbilt, Maximally localized Wannier functions: Theory and applications, *Rev. Mod. Phys.* **84**, 1419 (2012).
- [64] N. Marzari and D. Vanderbilt, Maximally localized generalized Wannier functions for composite energy bands, *Phys. Rev. B* **56**, 12847 (1997).
- [65] J. P. Perdew, K. Burke, and M. Ernzerhof, Generalized Gradient Approximation Made Simple, *Phys. Rev. Lett.* **77**, 3865 (1996).
- [66] S. H. Wei and A. Zunger, Electronic structure of M₃ISb-type filled tetrahedral semiconductors, *Phys. Rev. B* **35**, 3952 (1987).
- [67] A. R. Ettema and R. A. de Groot, Electronic structure of Cs₂KSb and K₂CsSb, *Phys. Rev. B* **66**, 115102 (2002).
- [68] L. Kalarasse, B. Bennecer, and F. Kalarasse, Optical properties of the alkali antimonide semiconductors Cs₃Sb, Cs₂KSb, CsK₂Sb and K₃Sb, *J. Phys. Chem. Solids* **71**, 314 (2010).
- [69] C. Cocchi and H. D. Saßnick, *Ab initio* quantum-mechanical predictions of semiconducting photocathode materials, *Micromachines* **12**, 1002 (2021).
- [70] H.-D. Saßnick and C. Cocchi, Electronic structure of cesium-based photocathode materials from density functional theory: Performance of PBE, SCAN, and HSE06 functionals, *Electronic structure and magnetism of inorganic compounds* **3**, 027001 (2021).
- [71] J. F. Moulder, W. F. Stickle, P. E. Sobol, and K. D. Bomben, *Handbook of X-ray Photoelectron Spectroscopy* (Perkin-Elmer Corporation, Eden Prairie, 1992).
- [72] J. Yeh and I. Lindau, Atomic subshell photoionization cross sections and asymmetry parameters: $1 \leq Z \leq 103$, *At. Data Nucl. Data Tables* **32**, 1 (1985).
- [73] M. A. H. Schmeißer, S. Mistry, H. Kirschner, S. Schubert, A. Jankowiak, T. Kamps, and J. Kühn, Towards the operation of Cs-K-Sb photocathodes in superconducting rf photoinjectors, *Phys. Rev. ST Accel. Beams* **21**, 113401 (2018).

- [74] C. D. Wagner, Chemical shifts of Auger lines, and the Auger parameter, *Faraday Discuss. Chem. Soc.* **60**, 291 (1975).
- [75] W. E. Morgan, W. J. Stec, and J. R. Van Wazer, Inner-orbital binding-energy shifts of antimony and bismuth compounds, *Inorg. Chem.* **12**, 953 (1973).
- [76] J. Jupille, P. Dolle, and M. Besançon, Ionic oxygen species formed in the presence of lithium, potassium and cesium, *Surf. Sci.* **260**, 271 (1992).
- [77] S. J. Yang and C. W. Bates, The role of cesium suboxides in low-work-function surface layers studied by x-ray photoelectron spectroscopy: Ag-O-Cs, *Appl. Phys. Lett.* **36**, 675 (1980).
- [78] C. D. Wagner, D. A. Zatko, and R. H. Raymond, Use of the oxygen KLL Auger lines in identification of surface chemical states by electron spectroscopy for chemical analysis, *Anal. Chem.* **52**, 1445 (1980).
- [79] N. G. Krishnan, W. N. Delgass, and W. D. Robertson, Electron binding energies of core levels in caesium adsorbed on a nickel (100) surface, *J. Phys. F* **7**, 2623 (1977).
- [80] G. Ebbinghaus and A. Simon, Electronics structures of Rb, Cs and some of their metallic oxides studied by photoelectron spectroscopy, *Chem. Phys.* **43**, 117 (1979).
- [81] K. Momma and F. Izumi, VESTA3 for three-dimensional visualization of crystal, volumetric and morphology data, *J. Appl. Crystallogr.* **44**, 1272 (2011).
- [82] T. Maruyama, D.-A. Luh, A. Brachmann, J. E. Clendenin, E. L. Garwin, S. Harvey, J. Jiang, R. E. Kirby, C. Y. Prescott, R. Prepost, and A. M. Moy, Systematic study of polarized electron emission from strained GaAs/GaAsP superlattice photocathodes, *Appl. Phys. Lett.* **85**, 2640 (2004).
- [83] W. Liu, Y. Chen, W. Lu, A. Moy, M. Poelker, M. Stutzman, and S. Zhang, Record-level quantum efficiency from a high polarization strained GaAs/GaAsP superlattice photocathode with distributed Bragg reflector, *Appl. Phys. Lett.* **109**, 252104 (2016).
- [84] J. Marini, I. Mahaboob, E. Rocco, L. D. Bell, and F. Shahedipour-Sandvik, Polarization engineered *N*-polar Cs-free GaN photocathodes, *J. Appl. Phys.* **124**, 113101 (2018).
- [85] A repository at <https://doi.org/10.34863/6d5f-aj24> contains detailed growth parameters, as well as XPS and ARPES characterization data, for the samples prepared and measured in the course of this investigation.